

# weekly meeting J-PARC E80

- check the validity of BLDC residuals
- looked the histograms of CDC Raw Hist

2024/7/1 Yuto Kimura, RARIS, J-PARC E80

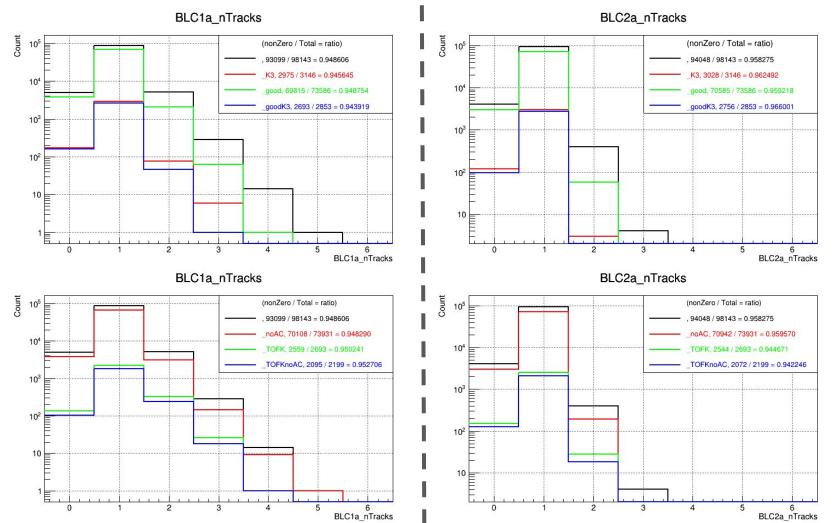


# BLDC



#### The number of tracks

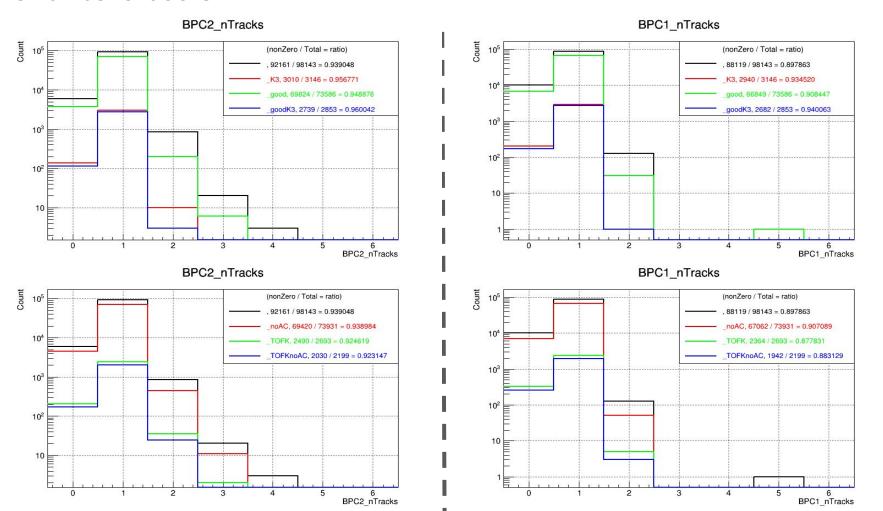
- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
  - loop ~100,000 events





#### The number of tracks

- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop ~100,000 events

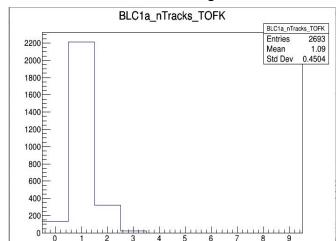


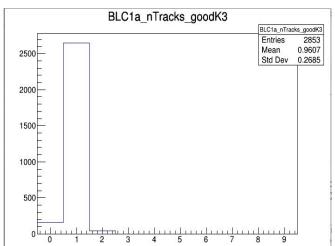


### The number of tracks

- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop ~100,000 events
- "strongK" means "TOFK && GoodBeam && K3"

?





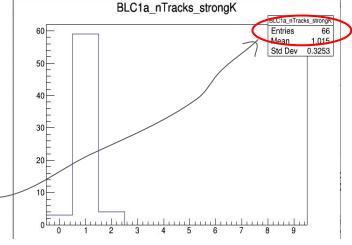
- Intuitively, in venn diagram, area of TOFK and area of goodK3
  are overlapped each other, namely, they are not independent.
- But they look independent from these histograms.
- Because,
   P(TOFK) = 0.027

P(TOFK) = 0.027, P(goodK3) = 0.029

 $\rightarrow$  if they are independent,

we can guess  $P(strongK) = P(TOFK) \times P(goodK3) = 0.00078$ 

→ 100,000 events × 0.00078 < 78 events of "strongK"</p>







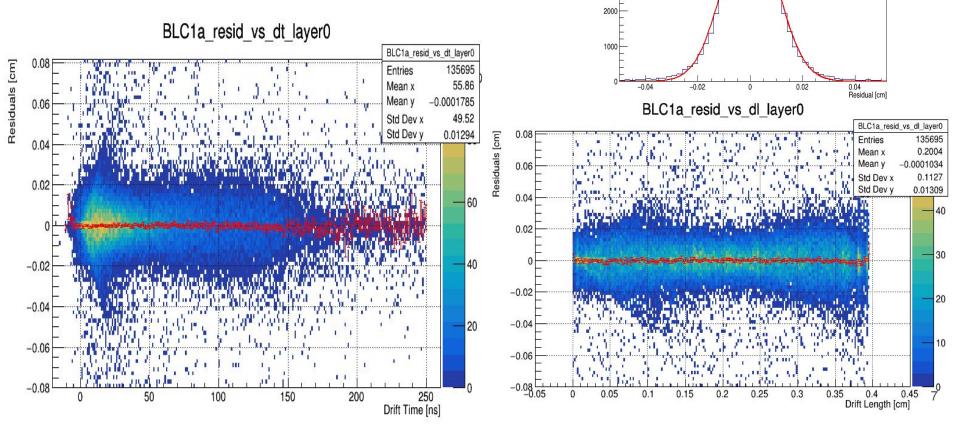
- E73 2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop 1,000,000 events

in UserDC.cc, added them to make hist of dt vs resid

```
#endif
     for(int itr=0;itr<ntra;itr++){
        LocalTrack* track=DCAna->GetTrack(cid,itr);
#if 0
        for(int i=0;i<track->nclustertimes();i++){
          std::cout<<i<" "<<track->clustertime(i)<<std::endl;</pre>
       std::cout<<"Time: "<<track->GetTrackTime()<<std::endl;</pre>
        std::cout<<"RMS: "<<track->GetTrackTimeRMS()<<std::endl;</pre>
#endif
       hist::H1(tmpname+"_time", track->GetTrackTime(),2000,-200,200);
       hist::H1(tmpname+" timerms", track->GetTrackTimeRMS(), 1000, 0, 200);
     if(ntra==1&&Single[ichm]){
       LocalTrack* track=DCAna->GetTrack(cid,0);
       hist::H1(tmpname+"_chi2all",track->chi2all(),1000,0,100);
       hist::H1(tmpname+"_chi2xz", track->chi2xz(),1000,0,100);
       hist::H1(tmpname+" chi2yz", track->chi2yz(),1000,0,100);
       double x, y;
       track->XYLocalPosatZ(0,x,y);
       hist::H2(tmpname+"_XYLocal",x,y,posbins2);
       hist::H2(tmpname+" AB", track->gdx(), track->gdy(), 100, -0.1, 0.1, 100, -0.1, 0.1);
        for(int xy=0;xy<2;xy++){
         for(int i=0;i<track->nhit(xy);i++){
           double resid=track->resid(xy,i);
           int layer=track->layer(xv.i):
            double dt=track->hit(xy,0).dt;
           hist::H1(tmpname+"_resid"+Form("_layer%d", layer), resid, residbins);
            hist::H2(tmpname+" FvNum dF"+Form(" laver%d", laver ) event number resid evresidbins):
            hist::H2(tmpname+"_resid_vs_dt"+Form("_layer%d", layer ),dt,resid,500,-100,400,100,-0.1,0.1)
```



- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop 1,000,000 events, the number of tracks =1 && Single[each detector] 5/8
- BLC1a, Layer0
- Drift Time vs Residual, and Mean of Residual in each x-bins (left)
- Drift Length vs Residual, and Mean of Residual in each x-bins (left)
- Gaussian fit result (upper right)
- $\bullet \quad \text{ almost flat and one peak} \to \mathsf{XT} \ \mathsf{param} \ \mathsf{OK}$



BLC1a resid layer0

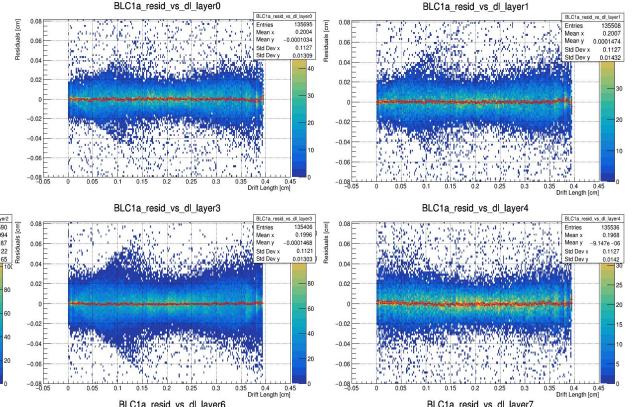
0.01139

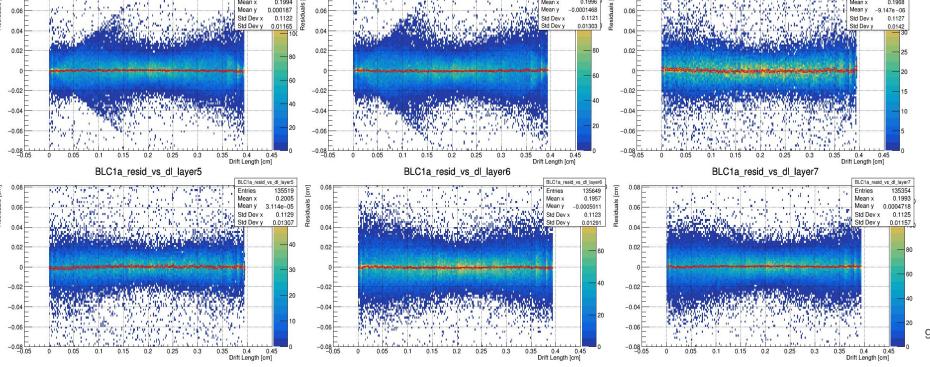
Mean = -1 [um] Sigma = 102 ± 0 [um]

250 Drift Time [ns] 250 Drift Time [ns]

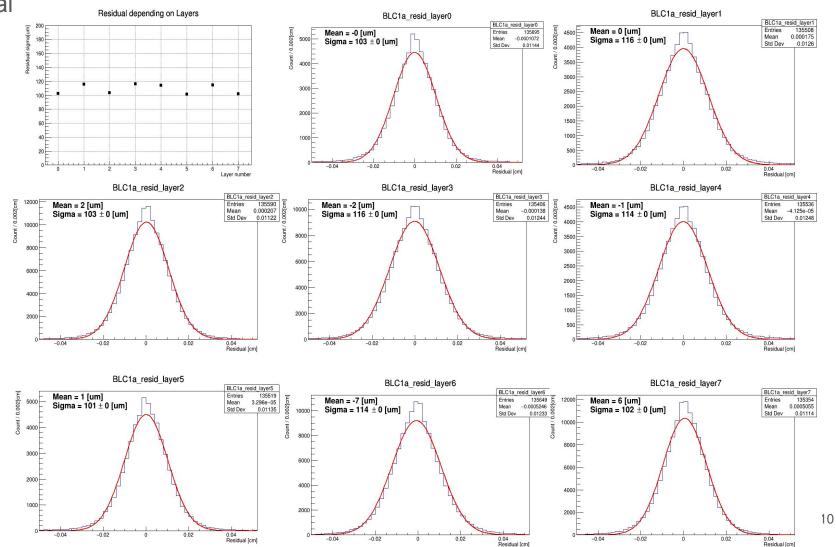
# Drift Length vs Residual BLC1a

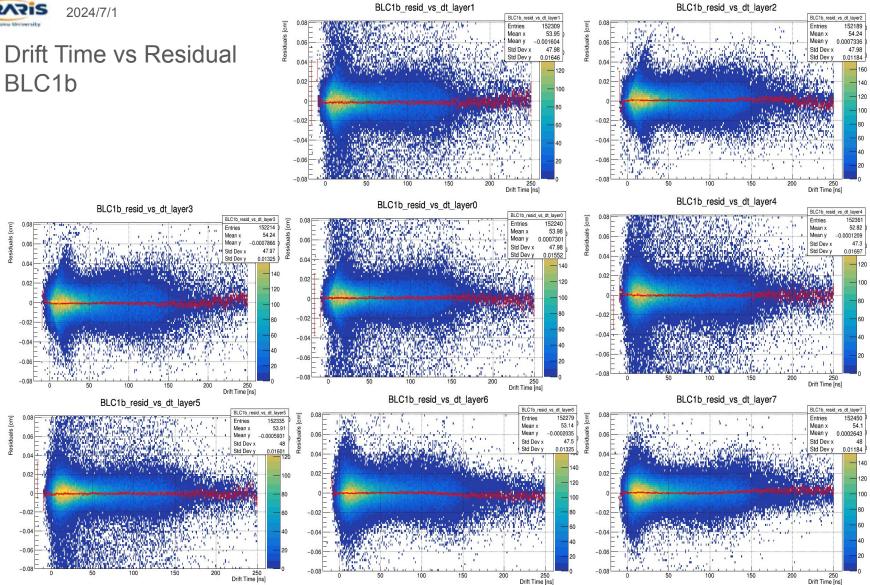
BLC1a\_resid\_vs\_dl\_layer2





Residual BLC1a





0.04 0.02

-0.02

-0.04

0.02

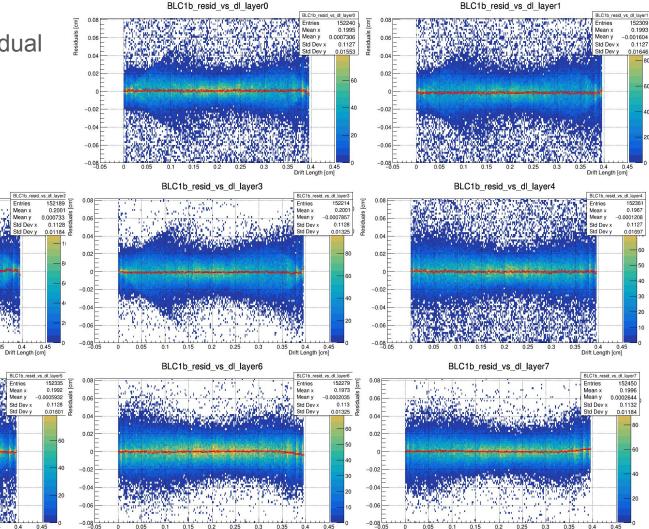
-0.02-0.04-0.06

# Drift Length vs Residual BLC1b

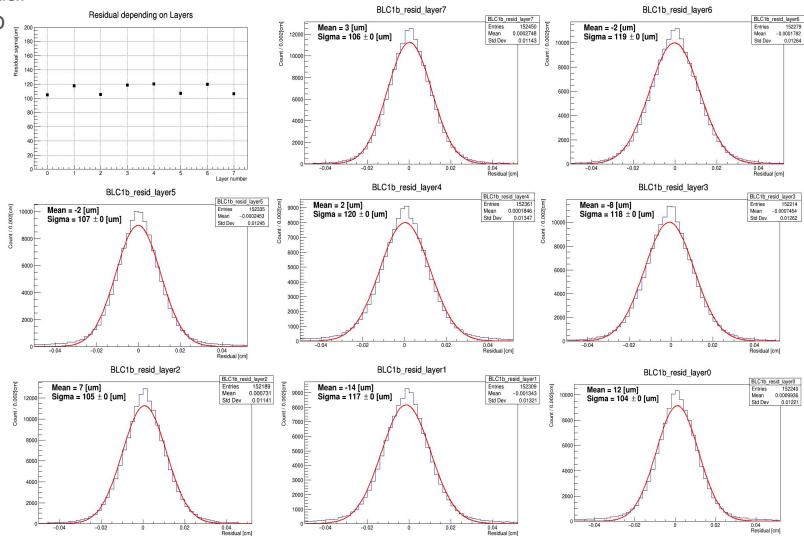
BLC1b\_resid\_vs\_dl\_layer2

BLC1b\_resid\_vs\_dl\_layer5

Entries

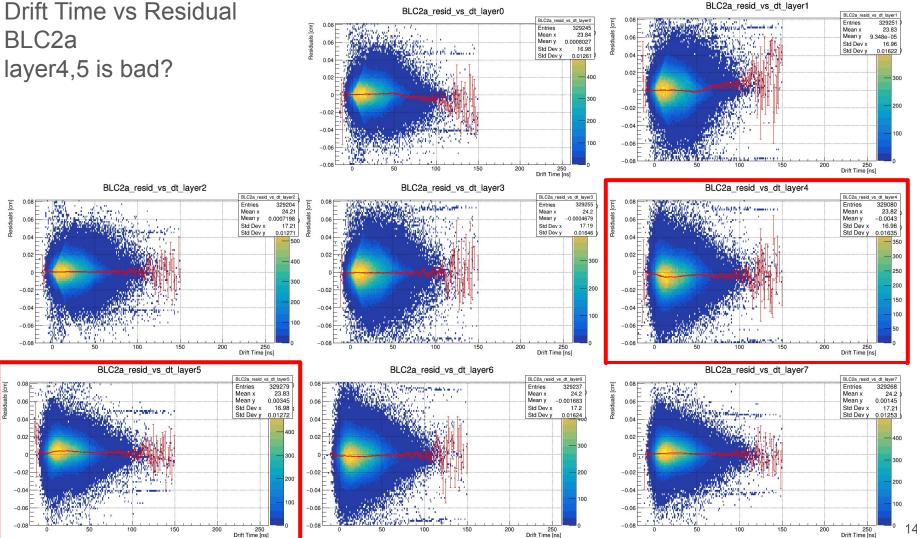


Residual BLC1b



Residual [cm]

**Drift Time vs Residual** 



0.02

-0.02

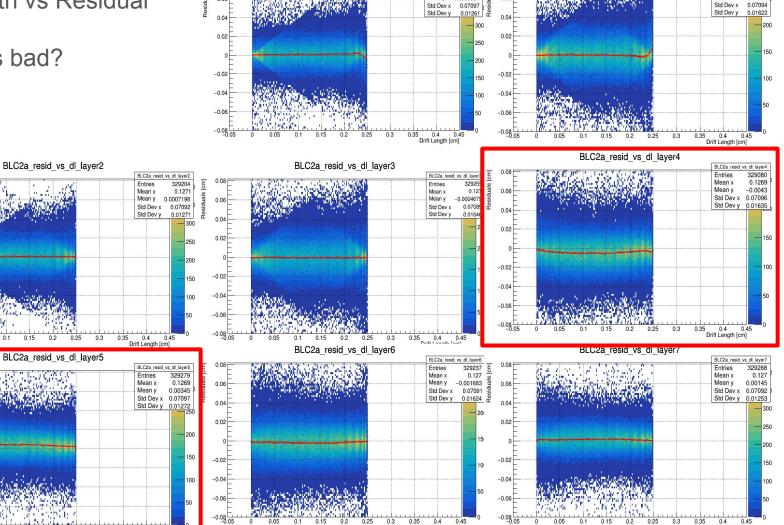
-0.04

-0.06

0.02

-0.04

# Drift Length vs Residual BLC2a layer4,5 is bad?



0.1269

0.0008027

0.07097

BLC2a resid vs dl layer0

BLC2a resid vs dl layer1

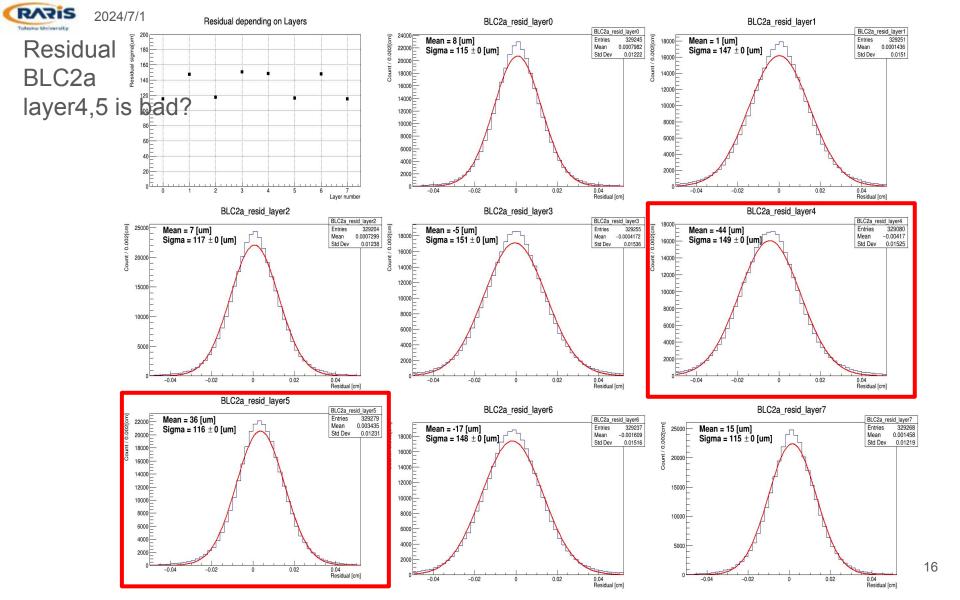
BLC2a resid vs dl layer1

0.07094

Mean x

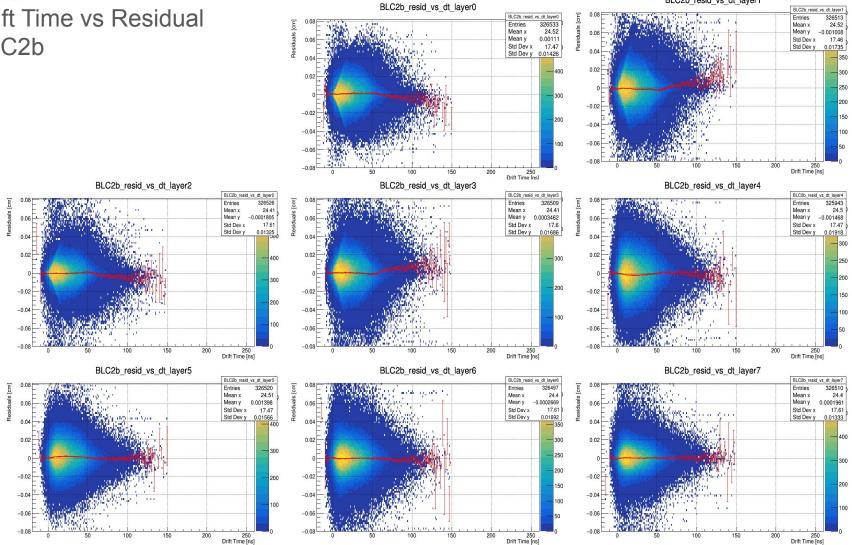
Mean y

Std Dev x



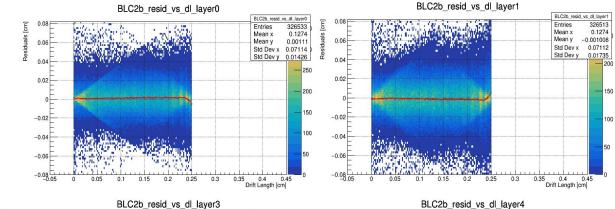


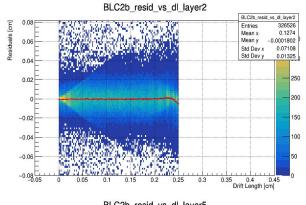
# **Drift Time vs Residual** BLC2b

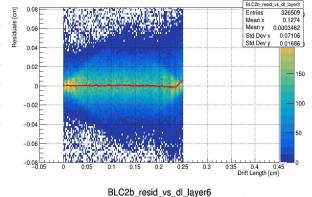


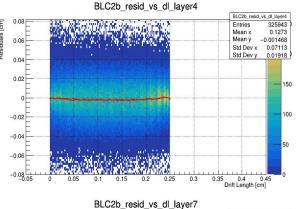
BLC2b resid vs dt layer1

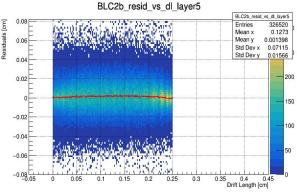
# Drift Length vs Residual BLC2b

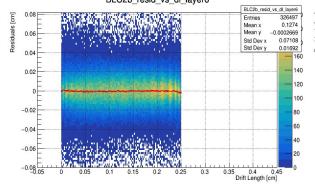


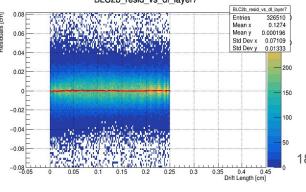












-0.04

-0.02

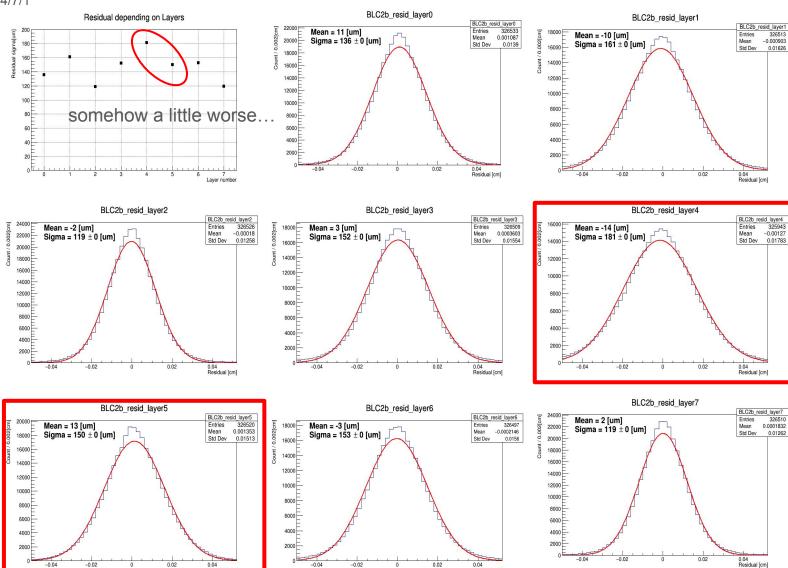
0.02

0.04 Residual [cm]

-0.04

-0.02

Residual BLC2b

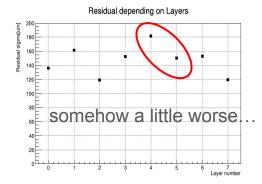


0.04 Residual [cm]

0.02



# Residual BLC2b



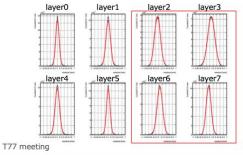
The same problem as Akaishi-san's analysis?

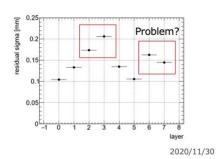
# BLC2a residuals

- T77 data
- >Run00094(production run)
- ▶Event selection
  - ✓ TOFK
- √T0 single hit
- ✓DT: -50 400 ns, TOT: 60 400 ns ✓Tracking required more than 3 layers each X, Y

√ 1 wire hit for each layer

#### Residual distribution





Run85

Run78

BLC1, BLC2 HV 1250 V **BPC HV 1500 V** 

BLC1, BLC2 HV 1250 V

(Kawasaki-san analysis 20180227)

BPC HV 1450 V BLC1a resid: ~ 0.14 mm



### BLC2a residuals

■ T77 data

T77 meeting

>Run00094(production run)

Residual distribution

layer0

✓ swapped layer3 with layer7… In cable connected BLC2a ASD output

layer1

layer5

layer2

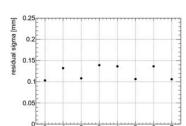
layer3

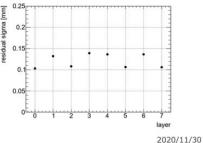
#### **BPC HV 1500 V** Run78

BLC1, BLC2 HV 1250 V BPC HV 1450 V

BLC1, BLC2 HV 1250 V

BLC1a resid: ~ 0.14 mm (Kawasaki-san analysis 20180227)







2024/7/1

**Drift Time vs Residual** BPC1 Layer1 is especially worse

BPC1\_resid\_vs\_dt\_layer2

BPC1\_resid\_vs\_dt\_layer5

Mean x

Mean y

Std Dev x

Std Dev y

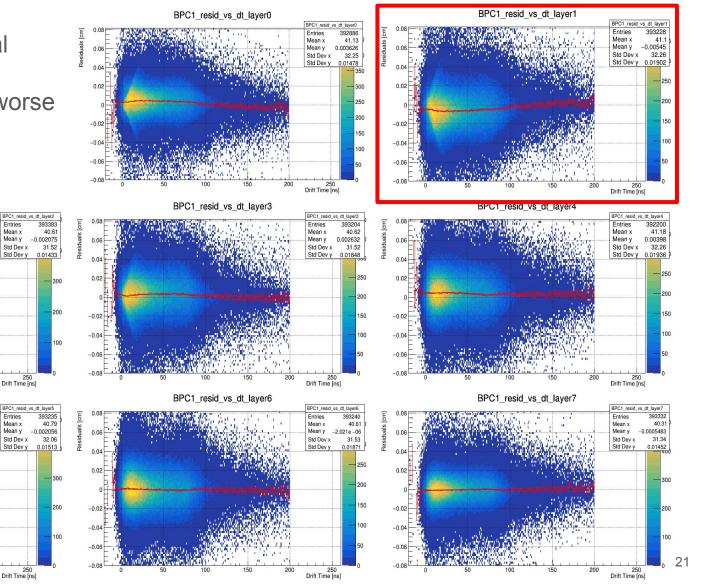
250 Drift Time [ns]

Mean x

Mean y

Std Dev x

250 Drift Time [ns]



2024/7/1

# Drift Length vs Residual BPC1 Layer1 is especially worse

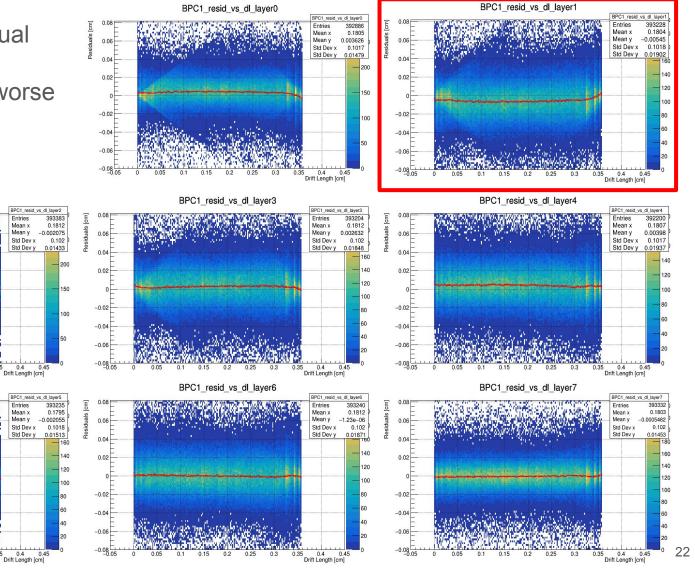
BPC1\_resid\_vs\_dl\_layer2

BPC1\_resid\_vs\_dl\_layer5

Std Dev x

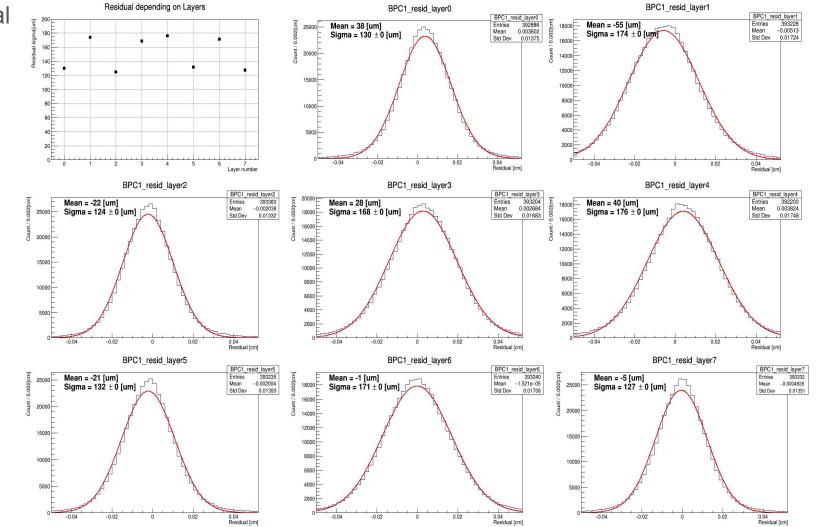
Std Dev v

Std Dev x

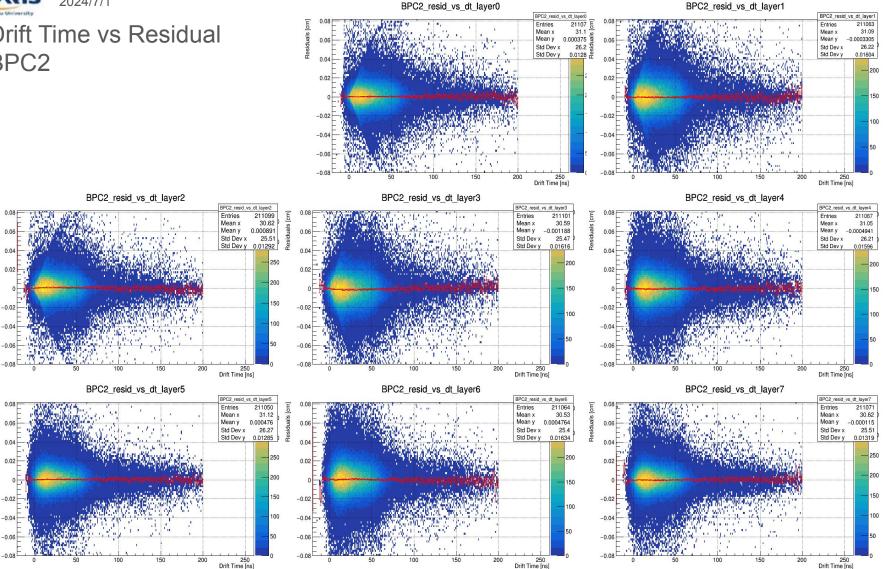




# Residual BPC1

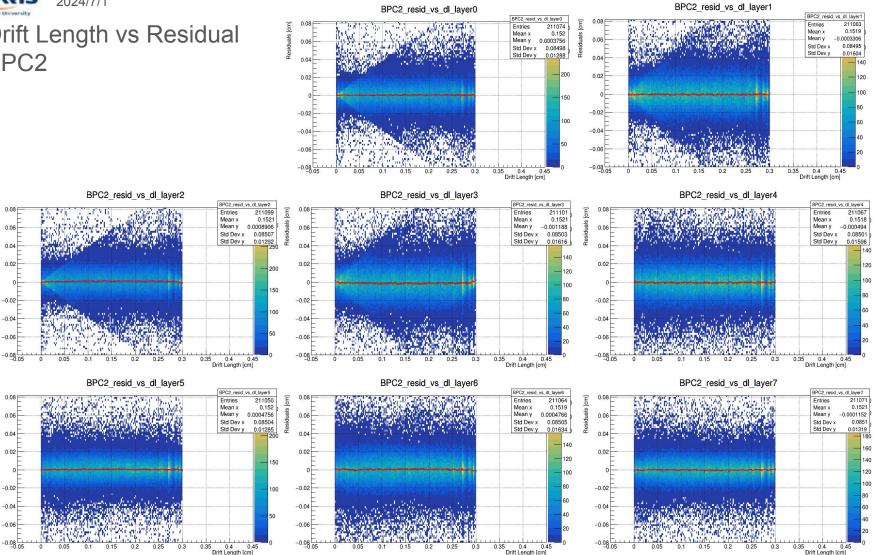


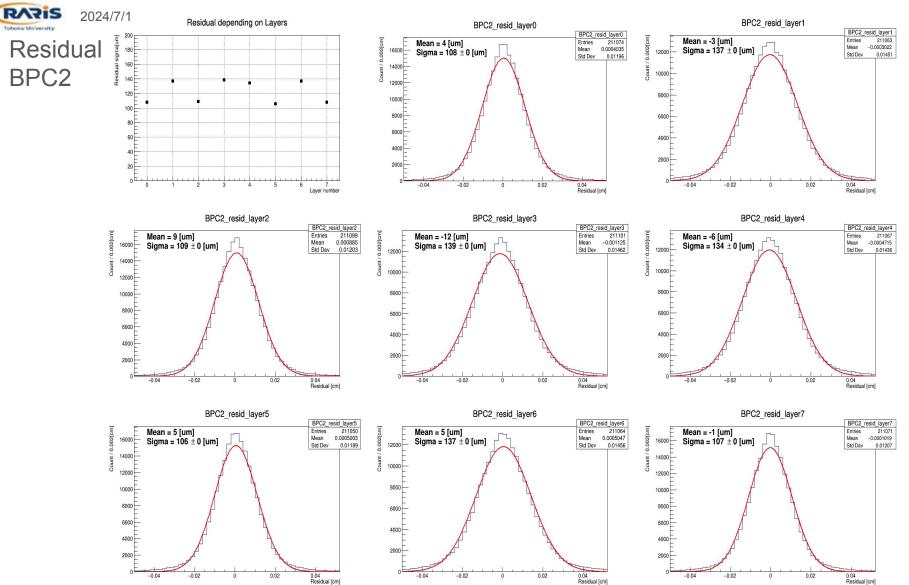
# **Drift Time vs Residual** BPC2





# Drift Length vs Residual BPC2

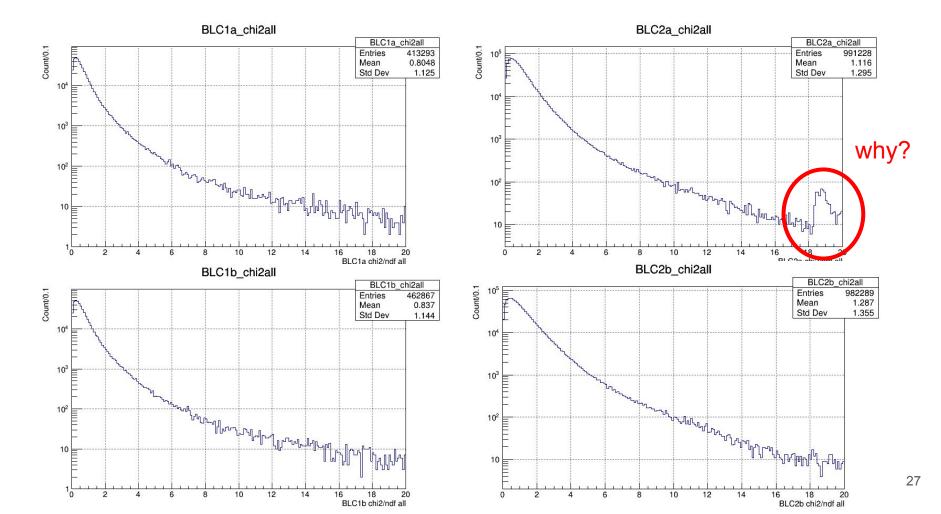






#### Chi2 distribution

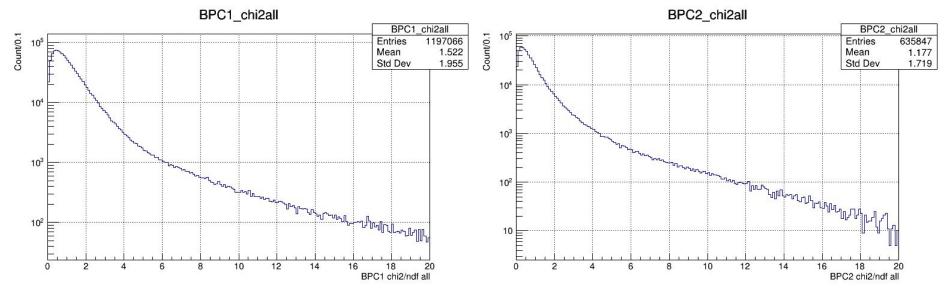
- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop ~3,000,000 events, nTracks =1 && Single[each detector]





#### Chi2 distribution

- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop ~3,000,000 events, nTracks =1 && Single[each detector]

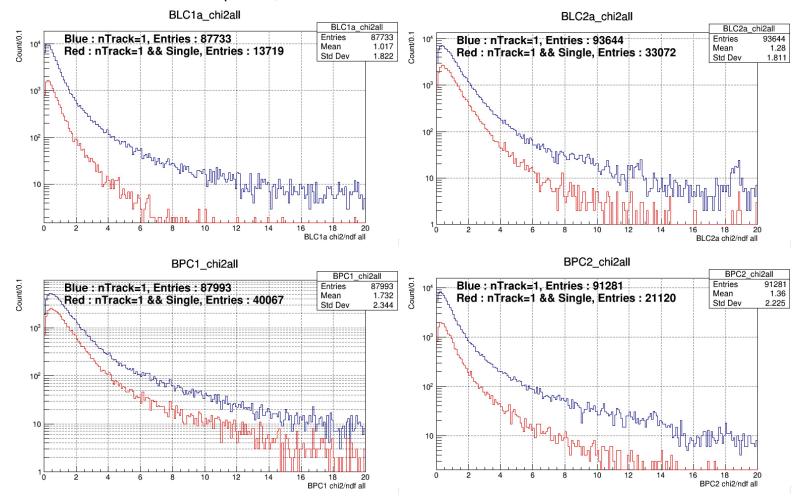


- Why is these entries "BPC1 > BLC2 > BPC2 > BLC1?" → pile up events?
- What is the hump of BLC2a at chi2/ndf ~ 19 ? → come from lack of wire



#### Chi2 distribution

- E73\_2nd Run955 (using XTparam optimizing Run955), Helium-3 production
- loop ~100,000 events



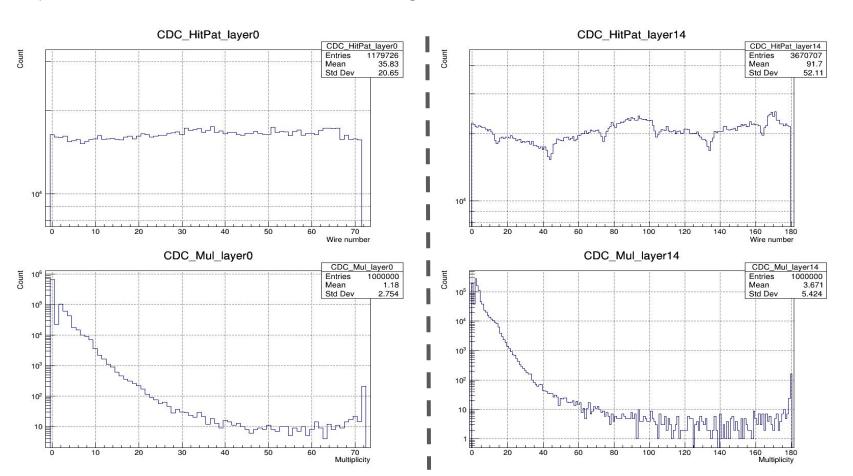


# CDC



#### CDC analysis

- First look of CDC Raw Histogram
  - HitPat, Multiplicity
- loop ~1,000,000, Run600, Cosmic data, w/o mag
- some structure in Layer14 HitPat
- non zero events Layer14 > Layer0



#### CDC analysis

First look of CDC Raw Histogram

o TOT

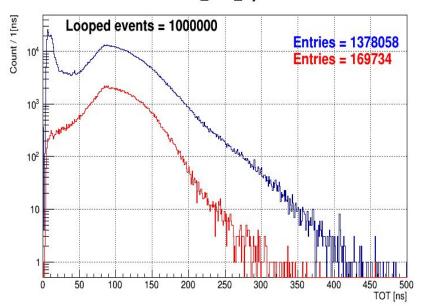
loop ~1,000,000, Run600, Cosmic data, w/o mag

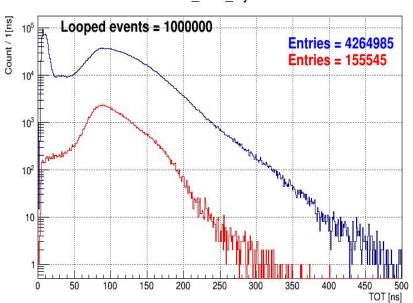
• Blue : Raw

• Red: "Single"... 2 hit in every layers && multiplicity >0 in each wire

CDC\_TOT\_layer0

CDC\_TOT\_layer14

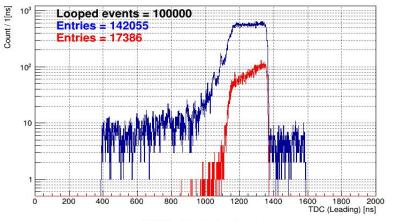




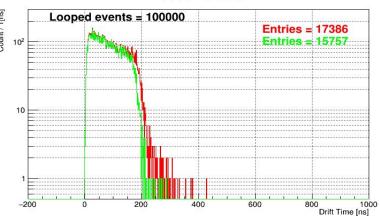


#### CDC analysis

- First look of CDC Raw Histogram
  - TDC, Drift Time(not adjust yet)
- loop ~100,000, Run600, Cosmic data, w/o mag CDC\_Leading\_layer0



CDC\_dt\_single\_layer0

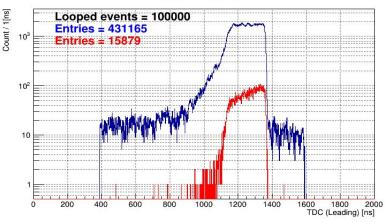


Blue : Raw

Red: "Single"... 2 hit in every layers
 && multiplicity >0 in each layer

• Green: "Single" && TOT>50

CDC\_Leading\_layer14



CDC\_dt\_single\_layer14



# Status

- checked the validity of BLDC param (Layer dependense, chi2, dt vs resid...)
- looked the histograms of CDCRaw
  - HitPat, Multiplicity, TOT, TDC
- To Do by next meeting
  - look HitPat after cutting by CDH segments
  - (decide the XT parameters of CDC by each layer)
  - check the validity of the XT parameters
    - dt vs resid, dl vs resid, chi2, wire dependence Efficiency=適当に定義
  - look the number of tracks

CDCとBLDCの違いを考える。

(まずはaxial)

結果をいきなり

XTは無視

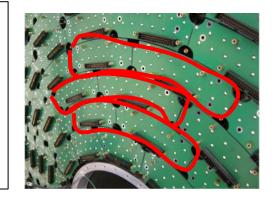
まずresid vs dt

分母CDH各レイヤーにHitがあるか

~ 7/10 : output the residual, tracking eff of CDC, for GPPU exam

### こういう配置でASD.トリガーの掛け方.

上下シンチだとアクセプタンスが小さすぎるか、、、、 中にもシンチ?-->やめた方がいいかも ASD boardの形ってどうだったっけ?-->一意







# Schedules

- June 13 ~ Jul. 20 : Sendai (intensive lecture 7/1~3, 7/10~12, 7/17~19), GPPU deadline Jul. 16 ~ 19
- Jul. 21 ~ Aug. 3: Tokai, work for new CDC (← GPPU exam (unclear)) ← 宿(ドミトリー)確保
- Aug. 4 ~ 7 : Sendai (intensive lecture 8/5~7)
- お盆: Sendai or Aomori
- Aug. 18 ~ Sep. 13 : Tokai, work and study for new CDC
- Sep. 14 : Sendai
- Sep. 15 ~ 20 : JPS in Hokkaido, Talk about CDC with ArCO2 (by cosmic data)
- Sep. 21 ~ : Tokai, study for new CDC
- Oct. 10 : Sendai or Tokai : Zasshi-kai of RARiS
- Nov. ~ ? : Tokai, J-PARC E73\_2'
- Jan.:後期課程進学願書提出